Application/Control No. O9/690,330 Applicant(s)/Patent Under Reexamination KIKKAWA ET AL. Examiner Thoi V Duong Applicant(s)/Patent Under Reexamination KIKKAWA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-		****	
	В	US-			
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NON-PATENT DOCUMENTS

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